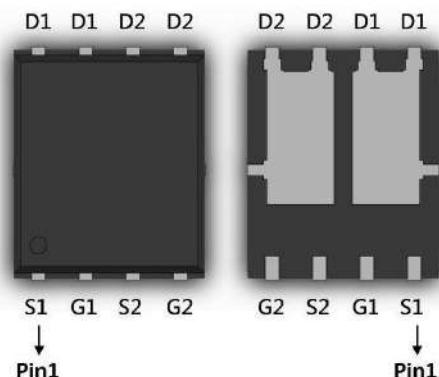


## Dual N-Channel Enhancement Mode Power MOSFET

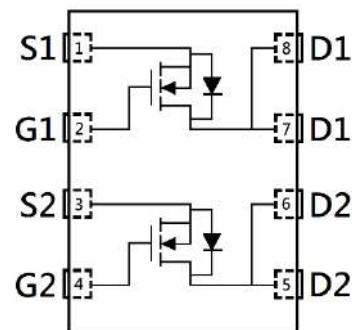
### Features:

- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic

DFN5x6



BVDSS	30V
Id@VGS=10V, Tc=25°C	27A
Id@VGS=10V, Ta=25°C	8.4A
RDS(ON)typ. @ VGS=10V, Id=8A	11mΩ
RDS(ON)typ. @ VGS=4.5V, Id=6A	16mΩ



G : Gate S : Source D : Drain

### Ordering Information

Device	Package	Shipping
KPRB012A03	DFN5x6 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel



### Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DS</sub>	30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =25°C	I <sub>D</sub>	27	A
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>C</sub> =100°C		17	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =25°C		8.4	
Continuous Drain Current @ V <sub>GS</sub> =10V, T <sub>A</sub> =70°C		6.7	
Pulsed Drain Current	I <sub>DM</sub>	80	
Continuous Body Diode Forward Current @ T <sub>C</sub> =25°C	I <sub>S</sub>	19	
Avalanche Current @ L=0.1mH	I <sub>AS</sub>	15	
Avalanche Energy @ L=0.5mH	E <sub>AS</sub>	16	mJ
Total Power Dissipation	T <sub>C</sub> =25°C	*a 23	W
	T <sub>C</sub> =100°C	*a 9.4	
	T <sub>A</sub> =25°C	*b 2.2	
	T <sub>A</sub> =70°C	*b 1.4	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

### Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	R <sub>θJC</sub>	5.3	°C/W
Thermal Resistance, Junction-to-ambient	R <sub>θJA</sub>	57	

Note:

- \*a. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- \*b. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR -4 board with 2 oz. copper, in a still air environment with T<sub>A</sub>=25°C. The power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- \*c. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and low duty cycles to keep initial T<sub>J</sub>=25°C.

### Electrical Characteristics ( $T_A=25^\circ\text{C}$ , unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	1	-	2.5		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	6.3	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =3A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V
R <sub>DSS(ON)</sub>	-	11	15	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =8A
	-	16	23		V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A
<b>Dynamic</b>					
C <sub>iss</sub>	-	790	-	pF	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	110	-		
C <sub>rss</sub>	-	85	-		
R <sub>g</sub>	-	4	-	Ω	f=1MHz
Q <sub>g</sub> *1, 2	-	19	-	nC	V <sub>DS</sub> =15V, I <sub>D</sub> =8A, V <sub>GS</sub> =10V
Q <sub>gs</sub> *1, 2	-	2.8	-		
Q <sub>gd</sub> *1, 2	-	4	-		
t <sub>d(ON)</sub> *1, 2	-	8	-	ns	V <sub>DS</sub> =15V, I <sub>D</sub> =8A, V <sub>GS</sub> =10V, R <sub>GS</sub> =1Ω
t <sub>r</sub> *1, 2	-	17	-		
t <sub>d(OFF)</sub> *1, 2	-	40	-		
t <sub>f</sub> *1, 2	-	9	-		
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	0.84	1.2	V	I <sub>S</sub> =8A, V <sub>GS</sub> =0V
trr	-	9	-	ns	I <sub>F</sub> =8A, dI <sub>F</sub> /dt=100A/μs
Qrr	-	4	-	nC	

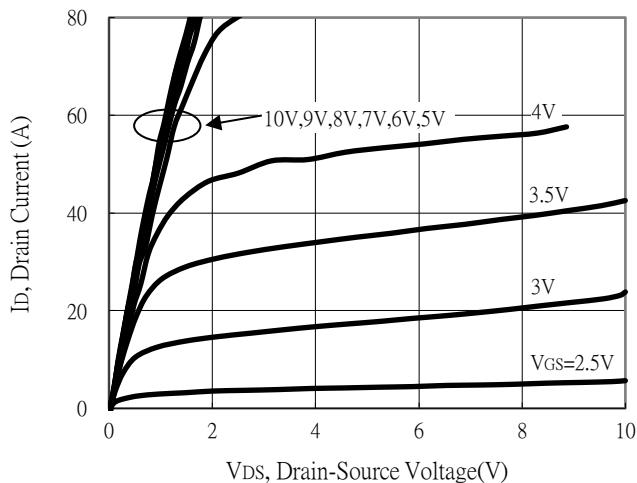
Note:

\*1. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$

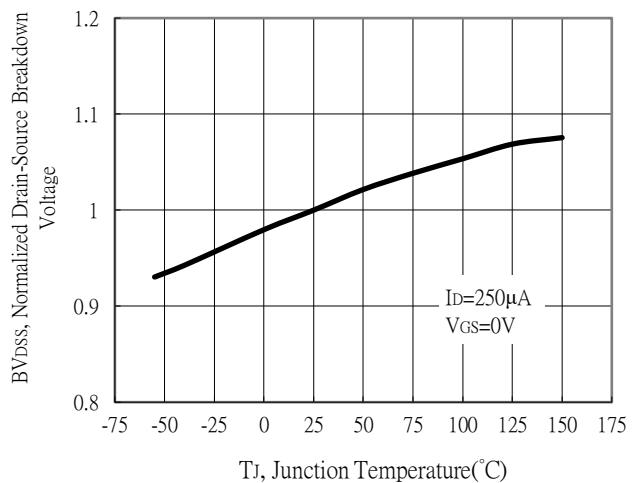
\*2. Independent of operating temperature

## Typical Characteristics

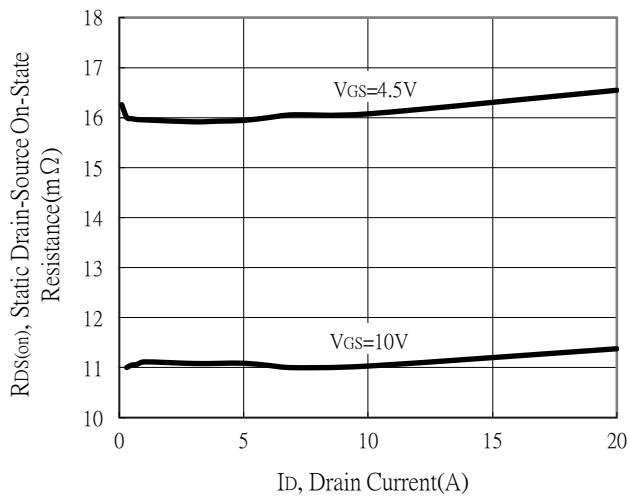
Typical Output Characteristics



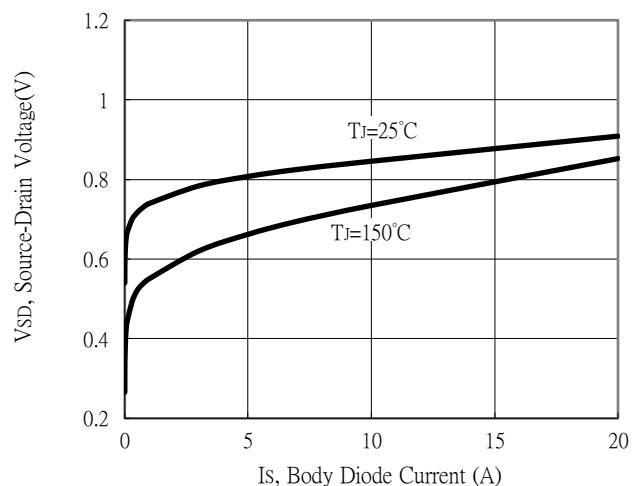
Breakdown Voltage vs Ambient Temperature



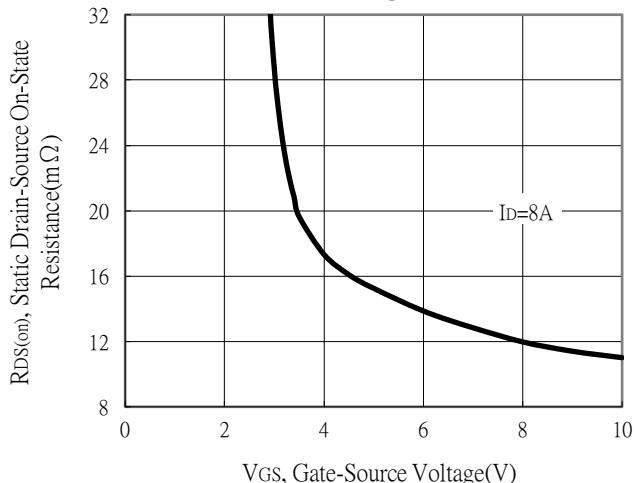
Static Drain-Source On-State resistance vs Drain Current



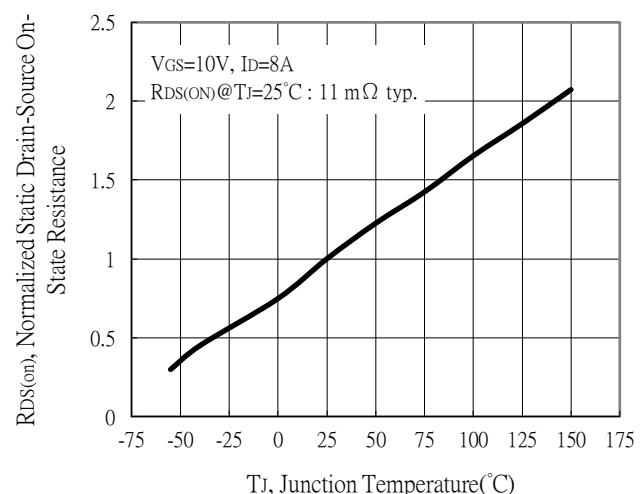
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

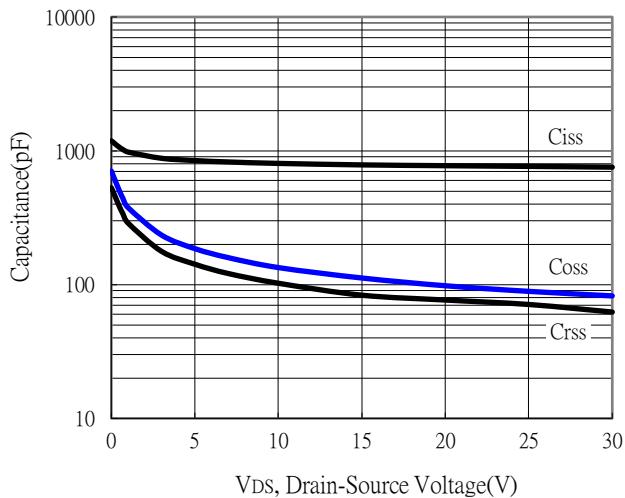


Drain-Source On-State Resistance vs Junction Temperature

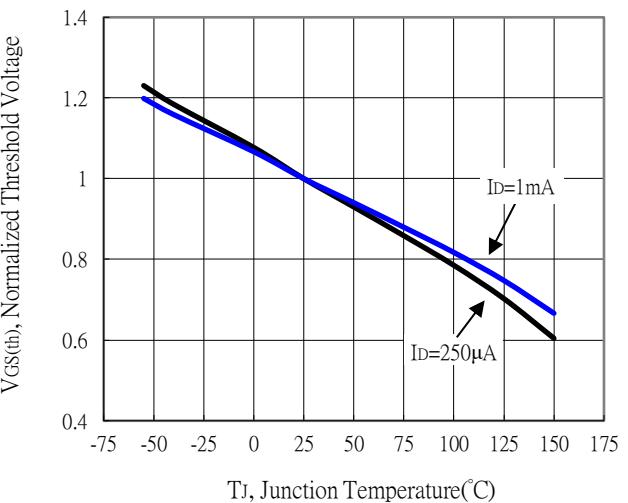


## Typical Characteristics (Cont.)

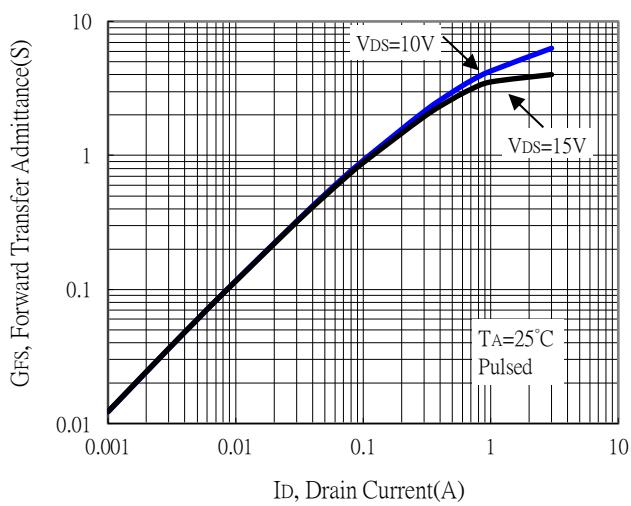
Capacitance vs Drain-to-Source Voltage



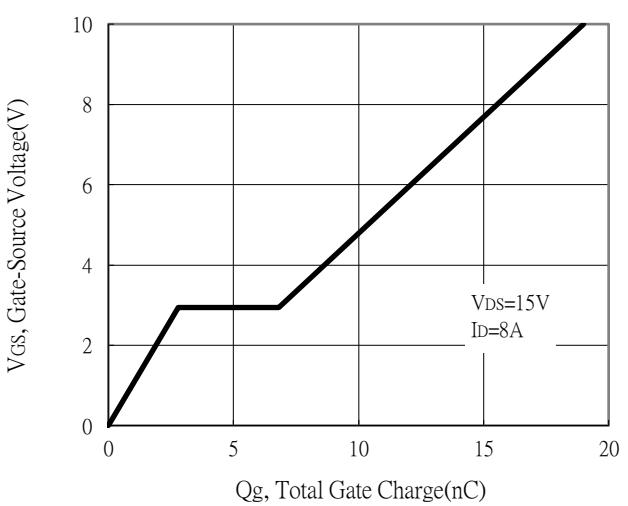
Threshold Voltage vs Junction Temperature



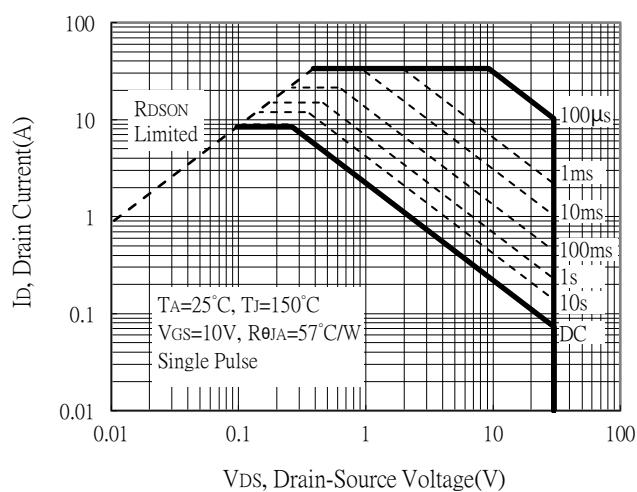
Forward Transfer Admittance vs Drain Current



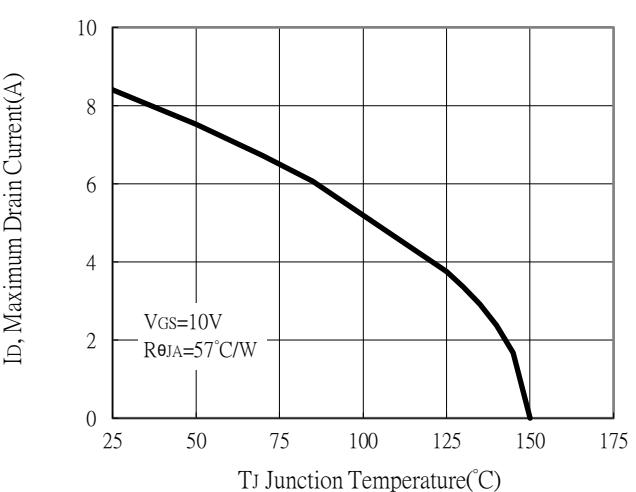
Gate Charge Characteristics



Maximum Safe Operating Area

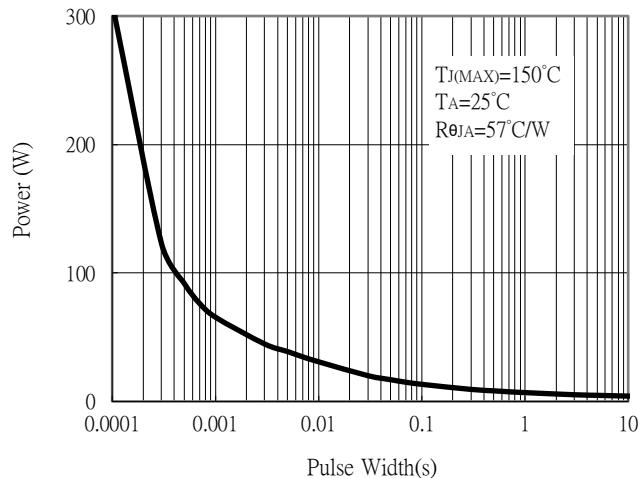


Maximum Drain Current vs Junction Temperature

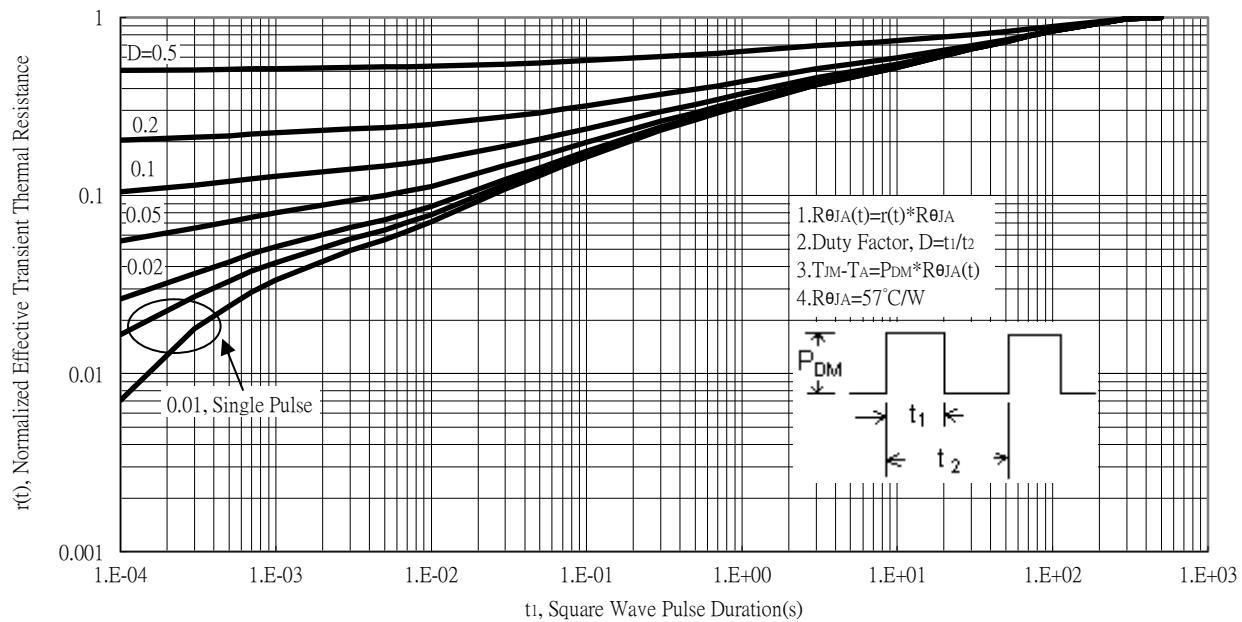


## Typical Characteristics (Cont.)

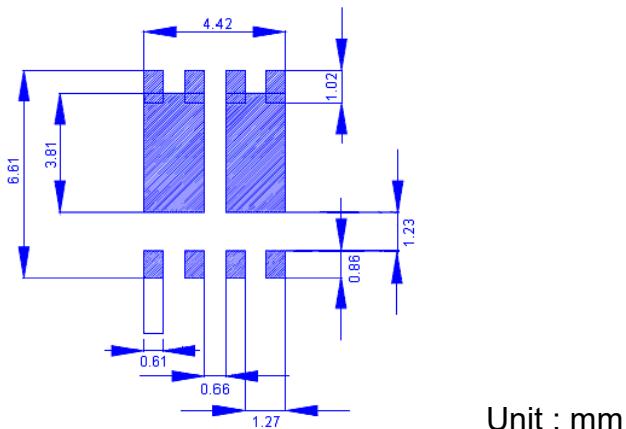
Single Pulse Power Rating, Junction to Ambient



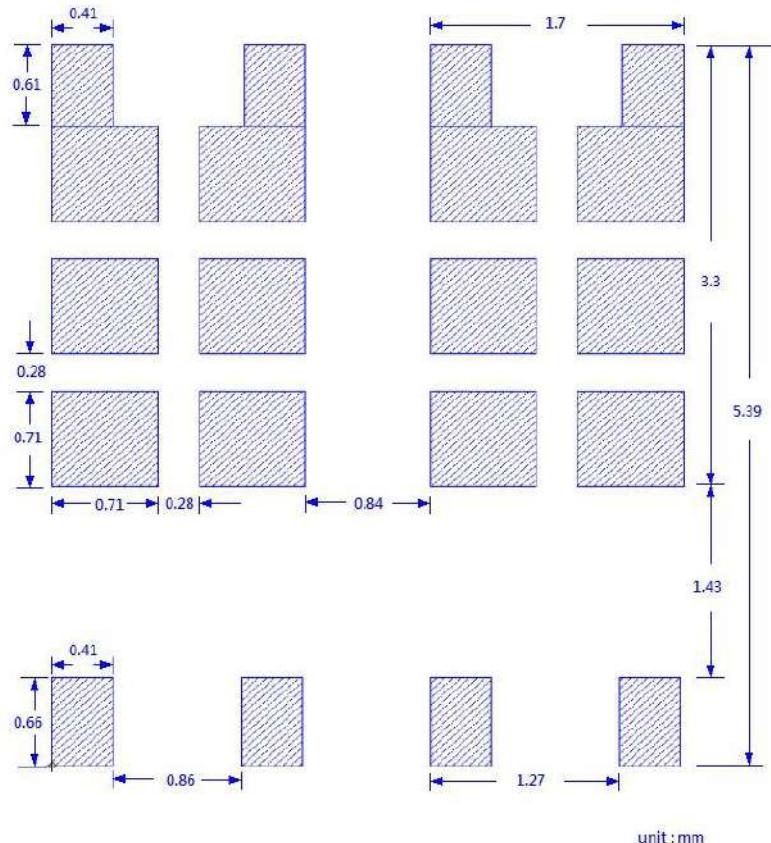
Transient Thermal Response Curves



## Recommended Soldering Footprint

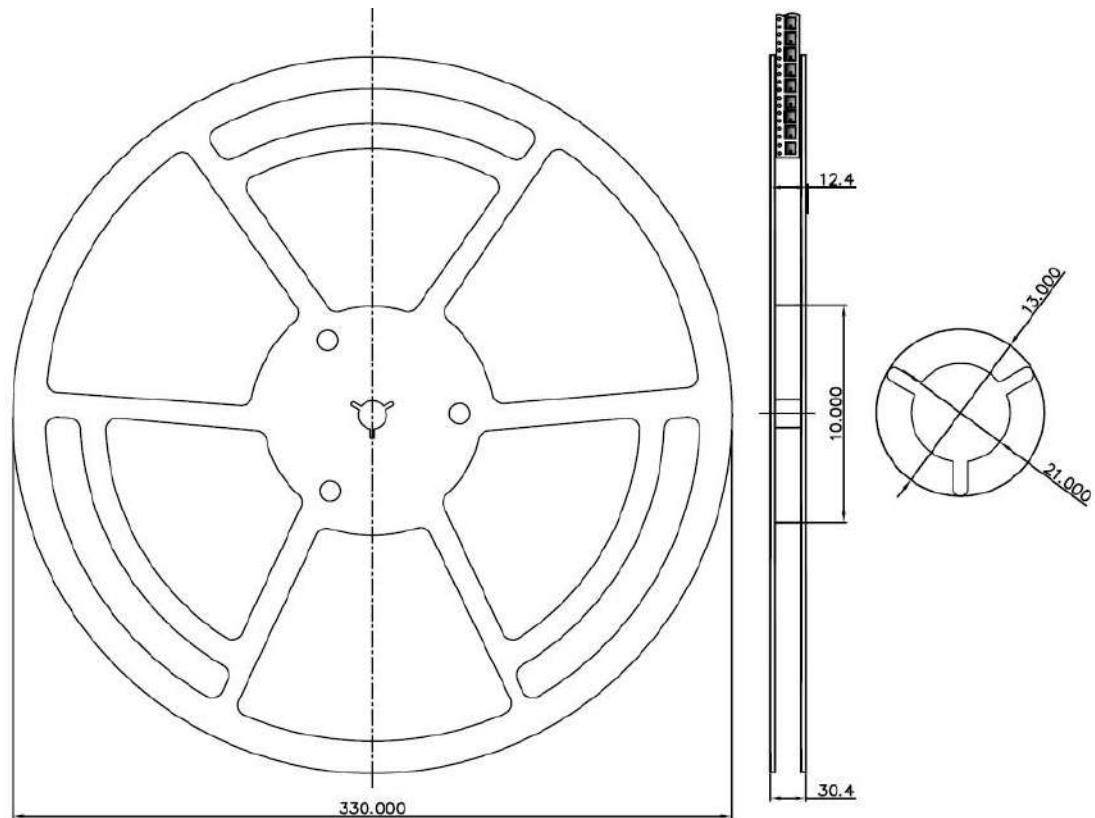


## Recommended Stencil Design

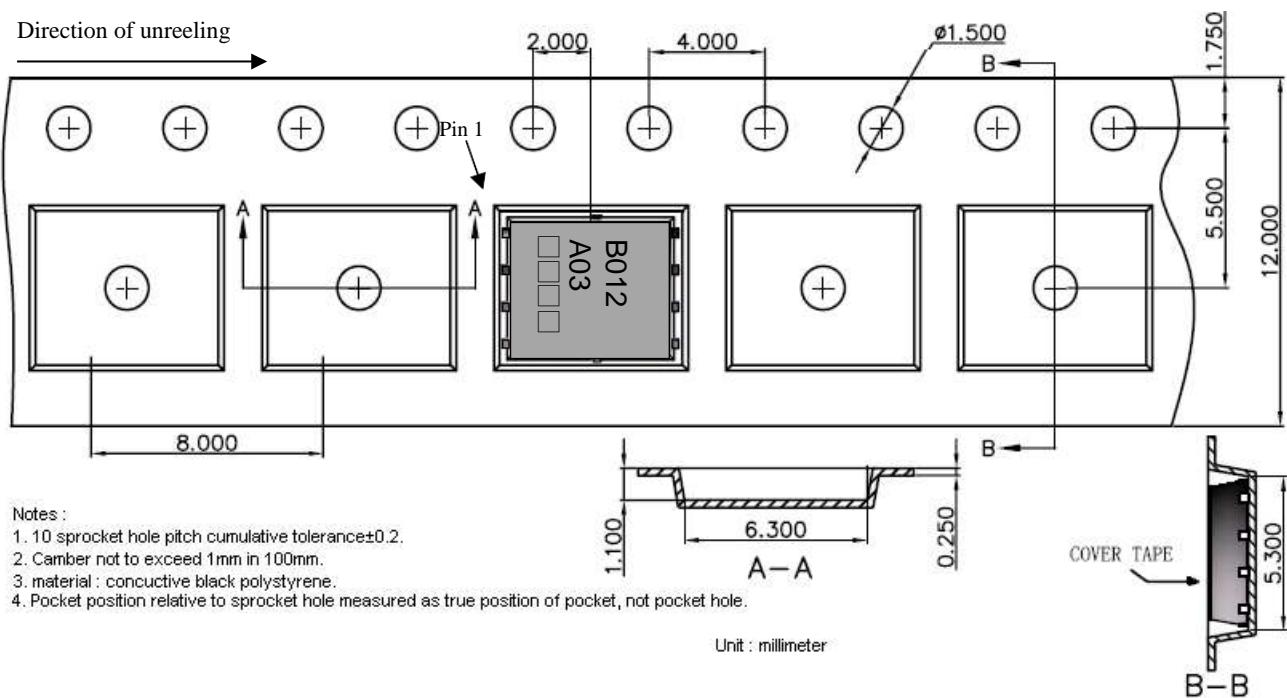


Note :  
1. Stencil thickness 5 mil (0.127mm)  
2. May need to be adjusted to specific requirements.

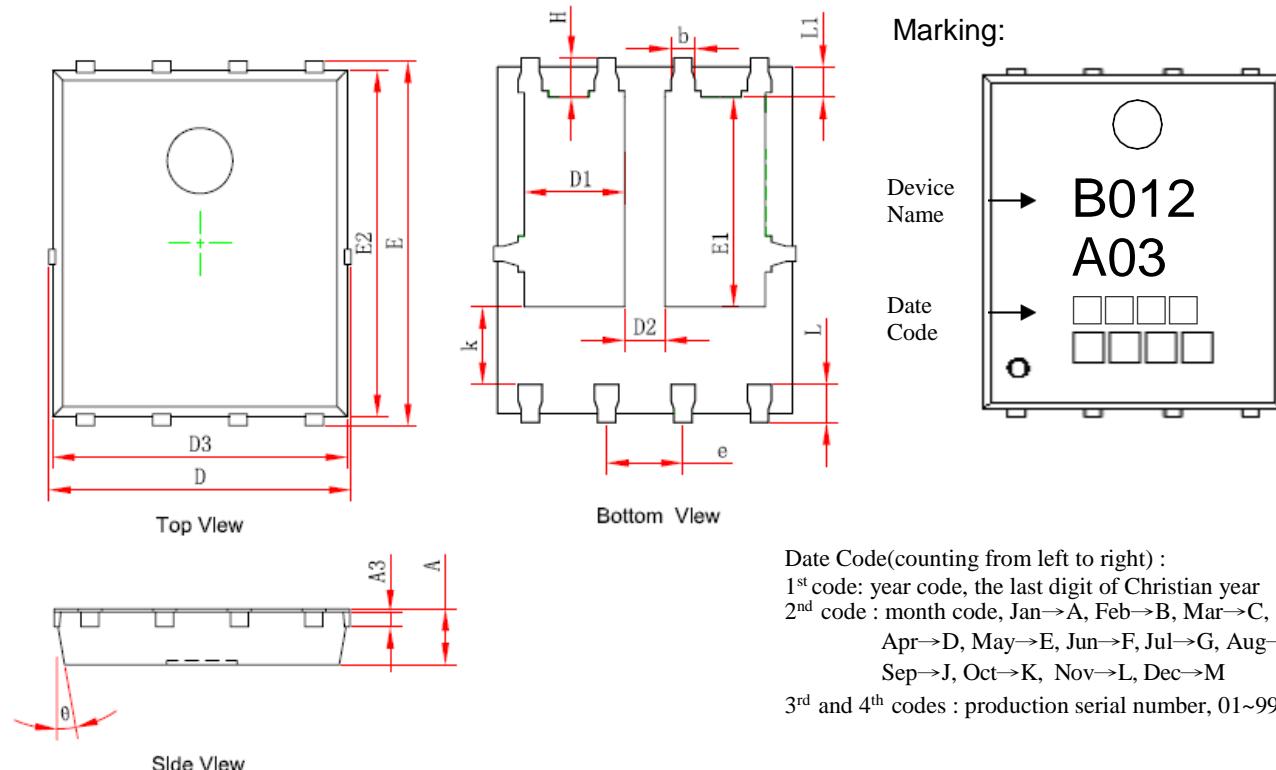
## Reel Dimension



## Carrier Tape Dimension



## DFN5x6 Dimension



8-Lead power pak Plastic Package

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039	E2	5.674	5.826	0.223	0.229
A3	0.254	REF	0.010	REF	k	1.190	1.390	0.047	0.055
D	4.944	5.096	0.195	0.201	b	0.350	0.450	0.014	0.018
E	5.974	6.126	0.235	0.241	e	1.270	TYP	0.050	TYP
D1	1.470	1.870	0.058	0.074	L	0.559	0.711	0.022	0.028
D2	0.470	0.870	0.019	0.034	L1	0.424	0.576	0.017	0.023
E1	3.375	3.575	0.133	0.141	H	0.574	0.726	0.023	0.029
D3	4.824	4.976	0.190	0.196	θ	10°	12°	10°	12°